



<p>Searched</p> 	<p>Application/Control No.</p> <p>10772889</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>RICHTSMEIER ET AL.</p>
	<p>Examiner</p> <p>Kaplan, Hal I</p>	<p>Art Unit</p> <p>2836</p>

Class	SubClass	Date	Examiner
200	309	09/14/2006	HK
200	552	09/14/2006	HK

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Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10772889	RICHTSMEIER ET AL.
	Examiner Kaplan, Hal I	Art Unit 2836

Notes	Date	Examiner
200/308-310,314,315,329,552,553 (consulted Michael Friedhofer)	09/14/2006	HK
399/3,32-39,81; 345/\$ (consulted Susan Lee)	09/14/2006	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TD B) - See Search History Printout	09/14/2006	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TD B) - See Search History Printout	09/15/2006	HK
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